# **3 Phase Inverter Automotive Power Module**

# FAM04V18DT1

# Features

- Full Bridge Inverter for Variable Speed Motor Drive
- Temperature Sensing
- R-C Snubber Circuits for each MOSFET
- Electrically Isolated DBC Substrate for Low Rthjc
- Compact Design for Low Total Module Resistance
- Module Serialization for Full Traceability
- Lead Free, RoHS and UL94 V-0 Compliant
- Automotive Qualified
- This Device is Pb-Free and is RoHS Compliant

## Applications

- 12 V Motor Control
- Brake System, Electrical Streering, Turbo Charger

## Benefits

- Enable Design of Small, Efficient and Reliable System for Reduced Vehicle Fuel Consumption and CO<sub>2</sub> Emission
- High Current Application
- Low Thermal Resistance
- Simplified Vehicle Assembly
- High EMI Performance

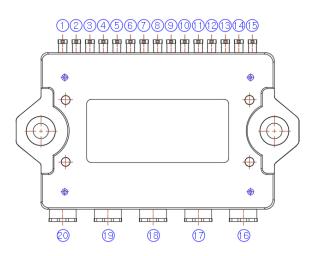


Figure 1. Pin Configuration



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APM20CBB / 20LD, CASE MODFZ

# ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

## Table 1. ORDERING INFORMATION

Part Number	Package	Pb–Free and RoHS Compliant	Operating Temperature Range	Packing Method
FAM04V18DT1	APM20-CBB	Yes	$-40C \sim 125^{\circ}C$	Tube

## Table 2. PIN DESCRIPTION

Pin No.	Pin Name	Pin Descriptions		
1	NTC+	NTC Thermistor Terminal 1		
2	NTC-	NTC Thermistor Terminal 2		
3	U_DN	Gate of Q4		
4	U_UP	Gate of Q1		
5	U_SENSE	Sense Pin for Source of Q1 and Drain of Q4		
6	V_DN	Gate of Q5		
7	V_UP	Gate of Q2		
8	NC	Not used		
9	V_SENSE	Sense Pin for Source of Q2 and Drain of Q5		
10	W_DN	Gate for Q6		
11	W_UP	Gate for Q3		
12	NC	Not used		
13	W_SENSE	Sense Pin for Source of Q3 and Drain of Q6		
14	V_LINK	Sense Pin for Battery Voltage and Drain of High Side MOSFETs		
15	BSENSE	B- Sense		
16	В-	Battery-		
17	B+	Battery+		
18	W Phase	W Phase Power lead		
19	V Phase	V Phase Power lead		
20	U Phase	U Phase Power lead		

# **Block Diagram**

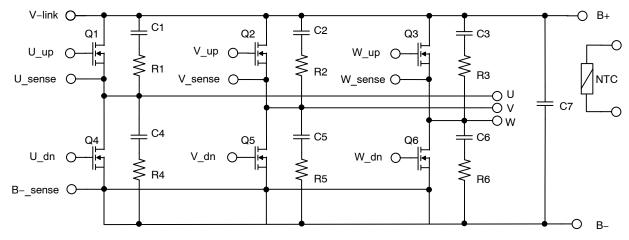


Figure 2. Schematic

Solder

Solder used is a lead free SnAgCu alloy.

## **Flammability Information**

All materials present in the power module meet UL flammability rating class 94 V-0.

### **Compliance to RoHS directives**

The power module is 100% lead free and RoHS compliant 2000/53/C directive.

### Table 3. ABSOLUTE MAXIMUN RATINGS (T<sub>J</sub> = 25°C, Unless Otherwise Specified)

Symbol	Parameter	Rating	Unit
V <sub>DS</sub> (Q1~Q6)	Drain to Source Voltage	40	V
V <sub>GS</sub> (Q1~Q6)	Gate to Source Voltage	±20	V
E <sub>AS</sub> (Q1~Q6)	Single Pulse Avalanche Energy (Note 1)	1466	mJ
Т <sub>Ј</sub>	Maximum Junction Temperature	175	°C
T <sub>STG</sub>	Storage Temperature	-40 ~ +125	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

### Table 4. ELECTRICAL SPECIFICATIONS (T<sub>J</sub> = 25°C, Unless Otherwise Specified)

	Parameter	Conditions	Min	Тур	Max	Unit
B <sub>VDSS</sub>	Drain-to-Source Breakdown Voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0 \ V$	40			V
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \ \mu A$	2		4	V
V <sub>SD</sub>	Source-to-Drain Diode Voltage	I <sub>SD</sub> = 80 A, V <sub>GS</sub> = 0 V			1.1	V
R <sub>DS(ON)</sub> Q1	Q1 Inverter High Side MOSFETs (Note 2)	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 80 A		0.60	0.85	mΩ
R <sub>DS(ON)</sub> Q2	Q2 Inverter High Side MOSFETs (Note 2)	V <sub>GS</sub> = 10 V,I <sub>D</sub> = 80 A		0.53	0.75	mΩ
R <sub>DS(ON)</sub> Q3	Q3 Inverter High Side MOSFETs (Note 2)	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 80 A		0.45	0.65	m۵
R <sub>DS(ON)</sub> Q4	Q4 Inverter Low Side MOSFETs (Note 2)	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 80 A		1.03	1.48	۵m
R <sub>DS(ON)</sub> Q5	Q5 Inverter Low Side MOSFETs (Note 2)	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 80 A		0.90	1.28	۳C
R <sub>DS(ON)</sub> Q6	Q6 Inverter Low Side MOSFETs (Note 2)	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 80 A		0.77	1.25	۳C
I <sub>GSS</sub>	Gate-to-Source Leakage Current	$V_{GS} = \pm 20$ V, $V_{DS} = 0$ V	-100		+100	nA
I <sub>DSS</sub>	Drain-to-Source Leakage Current	V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V			2	μA
	sistance, Total Module RDS(ON): tt(+) $\rightarrow$ Phase $\rightarrow$ GND(-)	$V_{GS}$ = 10 V, I <sub>D</sub> = 80 A		2.36	3.4	mΩ
Switching	Tdon, Turn-on delay time	$V_{GS}$ = 10 V, $V_{DD}$ = 14 V, $I_{D}$ = 30 A			500	nS
Characteristics	Tr, Rise time	]			400	nS
	Tdoff, Turn-off delay time	]			1000	nS
	Tf, Fall time				400	nS

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

 Starting T<sub>J</sub> = 25°C, L = 0.47 mH, I<sub>AS</sub> = 79 A, V<sub>DD</sub> = 40 V during inductor charging and V<sub>DD</sub> = 0 V during time in avalanche.
 All MOSFETs (bare die) have same die size and Rdson level, The different Rdson values listed in the datasheet are due to the different access points available inside the module for Rdson measurement.

# Table 5. TEMPERATURE SENSE (NTC THERMISTOR)

Parameter	arameter Test Conditions		Мах	Units
Resistance	Current = 1 mA	7.5	13	kΩ

## Table 6. MOSFETS RDSON MEASUREMENT PATHS

	+ Force	- Force	+ Sense	– Sense		+ Force	- Force	+ Sense	– Sense
Q1	B+	U phase	Vlink	U sense	Q4	U phase	B-	U sense	B- sense
	Pin 17	Pin 20	Pin 14	Pin 5		Pin 20	Pin 16	Pin 5	Pin 15
Q2	B+	V phase	Vlink	V sense	Q5	V phase	B-	V sense	B- sense
	Pin 17	Pin 19	Pin 14	Pin 9		Pin 19	Pin 16	Pin 9	Pin 15
Q3	B+	W phase	Vlink	W sense	Q6	W phase	B-	W sense	B- sense
	Pin 17	Pin 18	Pin 14	Pin 13		Pin 18	Pin 16	Pin 13	Pin 15

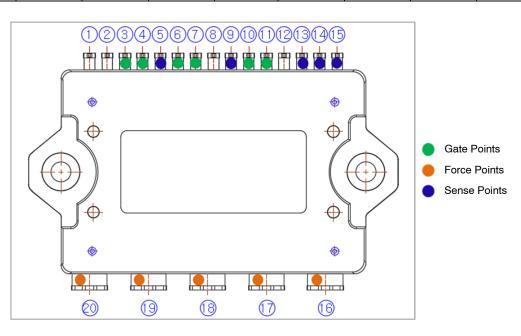


Figure 3.

	+ Force	- Force	+ Sense	– Sense		+ Force	- Force	+ Sense	<ul> <li>Sense</li> </ul>
Q1	B+	U phase	B+	U phase	Q4	U phase	B-	U phase	B-
	Pin 17	Pin 20	Pin 17	Pin 20		Pin 20	Pin 16	Pin 20	Pin 16
Q2	B+	V phase	B+	V phase	Q5	V phase	B-	V phase	B-
	Pin 17	Pin 19	Pin 17	Pin 19		Pin 19	Pin 16	Pin 19	Pin 16
Q3	B+	W phase	B+	W phase	Q6	W phase	B-	W phase	B-
	Pin 17	Pin 18	Pin 17	Pin 18		Pin 18	Pin 16	Pin 18	Pin 16

## Table 7. MODULE RDSON MEASUREMENT PATHS

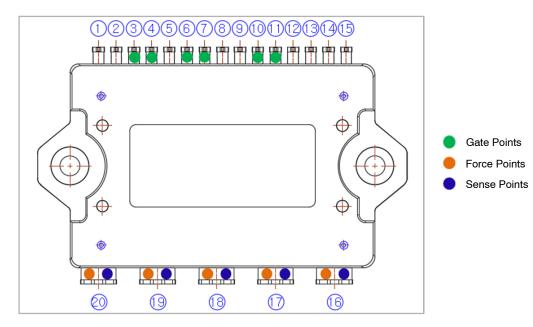


Figure 4.

## Table 8. THERMAL RESISTANCE

Parameter	Min	Тур	Max	Unit	
Rthjc Thermal Resistance Junction to case, Single Inverter FET	Q1–Q6 Thermal Resistance J–C	-	0.69	0.97	C/W

 Table 9. ISOLATION VOLTAGE
 (Isolation Voltage between DBC Bottom Surface and All Module Pins)

Test	Test Conditions	Min	Мах	Unit
Leakage @ Isolation Voltage (Hi–Pot)	VAC = 3 kV Frequency = 50 Hz Test Time = 1 s	_	300	μΑ

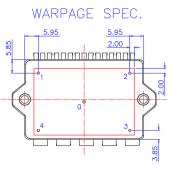
# Table 10. REFERENCE TYPICAL CHARACTERISTICS FOR DISCRETE MOSFET FDBL9401\_F085, USED IN HIGH SIDE AND LOW SIDE MOSFETS OF THIS MODULE

Symbol	Parameter	Test Conditions		Min	Тур	Max	Units
OFF CHAF	RACTERISTICS				1	1	
B <sub>VDSS</sub>	Drain-to-Source Breakdown Voltage	I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0 V		40	_	_	V
I <sub>DSS</sub>	Drain-to-Source Leakage Current	$V_{DS} = 40 V$ $T_{J} = 25^{\circ}C$		-	-	1	μA
		V <sub>GS</sub> = 0 V	T <sub>J</sub> = 175°C (Note 3)	-	-	1	mA
I <sub>GSS</sub>	Gate-to-Source Leakage Current	V <sub>GS</sub> = ±20 V		-	-	±100	nA
ON CHAR	ACTERISTICS						
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D =$	= 250 μA	2.0	3.0	4.0	V
R <sub>DS(on)</sub>	Drain to Source On Resistance	I <sub>D</sub> = 80 A	$T_J = 25^{\circ}C$	-	0.50	0.65	mΩ
		V <sub>GS</sub> = 10 V	T <sub>J</sub> = 175°C (Note 3)	-	0.86	1.10	mΩ
DYNAMIC	CHARACTERISTICS						
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 25 V, V <sub>GS</sub>	= 0 V	-	15900	_	pF
C <sub>oss</sub>	Output Capacitance	f = 1 MHz		-	4025	_	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	-		-	604	_	pF
Rg	Gate Resistance	f = 1 MHz		-	2.6	-	Ω
Q <sub>g(ToT)</sub>	Total Gate Charge at 10 V	V <sub>GS</sub> = 0 to 10	V <sub>DD</sub> = 20 V	-	220	-	nC
Q <sub>g(th)</sub>	Threshold Gate Charge	$V_{GS} = 0$ to 2 V	I <sub>D</sub> = 80 A	-	29	-	nC
Q <sub>gs</sub>	Gate to Source Gate Charge			-	73	-	nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge			-	41	-	nC
SWITCHIN	IG CHARACTERISTICS						
t <sub>on</sub>	Turn-On Time	$V_{DD}$ = 20 V, I <sub>D</sub> =	80 A	-	-	221	ns
t <sub>d(on)</sub>	Turn-On Delay	$V_{GS} = 10 \text{ V}, \text{ R}_{GE}$	<sub>N</sub> = 6 Ω	-	54	-	ns
tr	Rise Time			-	82	-	ns
t <sub>d(off)</sub>	Turn-Off Delay			-	106	-	ns
t <sub>f</sub>	Fall Time			-	52	-	ns
t <sub>off</sub>	Turn-Off Time			-	-	215	ns
DRAIN-SC	DURCE DIODE CHARACTERISTICS						
V <sub>SD</sub>	Source to Drain Diode Voltage	I <sub>SD</sub> = 80 A, V <sub>GS</sub>	= 0 V	-	-	1.25	V
		I <sub>SD</sub> = 40 A, V <sub>GS</sub>	= 0 V	-	-	1.2	V
t <sub>rr</sub>	Reverse Recovery Time	$I_F = 80 \text{ A}, \text{ dI}_{SD}/\text{dt}$	t = 100 A/µs	-	119	133	ns
Q <sub>rr</sub>	Reverse Recovery Charge	V <sub>DD</sub> = 32 V		-	228	274	nC

## Table 11. COMPONENTS

		Cor	nponent	Size	Maker	Remarks	
1	MOSFET	PT8 40 V	PT8 40 V, bare die used in FDBL9401	6ea	260 x 145 mil	ON Semiconductor	AEC Q101 qualified by FDBL9401_F085
2	R1, 2, 3, 4, 5, 6	Resistors	1406 10 Ω 200 mV 1%	6ea	2200 x 1100 [μm]	Vishay	AEC Q200 qualified
3	C1, 2, 3, 4, 5, 6	Capacitors	8200 pF 50 V 5%	6ea	2000 x 1250 [μm]	Murata	AEC Q200 qualified
4	C7	Capacitor	1206 100 nF 100 V 10%	1ea	2010 x 1250 [μm]	Murata	AEC Q200 qualified
5	NTC	Thermistor	NCP18XH103F0SRB - 10 kΩ	1ea	1600 x 800 [μm]	Murata	AEC Q200 qualified

# **Mechanical Characteristics and Ratings**



Warpage Spec. of point 1, 2, 3, 4 :  $0\sim 200$ um

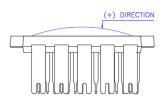
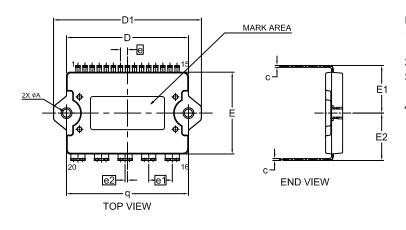


Figure 5.

#### PACKAGE DIMENSIONS

#### APM20CBB / 20LD, PDD STD, R-EPS MODULE CASE MODFZ ISSUF A



DETAIL B

Α2

SIDE VIEW

NOTES:

b3

b1

DETAIL B

L1

b2

DETAIL A

- 1. DIMENSIONING AND TOLERANCING PER. ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR EXTRUSIONS.
- 4. DIMENSION b and c APPLY TO THE PLATED LEADS AND ARE MEASURED BETWEEN 1.00 AND 2.00MM FROM THE LEAD TIP.

	MILLIMETERS					
DIM	MIN.	NOM.	MAX.			
А	25.00	25.30	25.60			
A2	7.00	7.20	7.40			
b	1.70	1.80	1.90			
b1	5.80	6.00	6.20			
b2	0.70	0.80	0.90			
b3	1.40	1.50	1.60			
С	0.75	0.80	0.90			
D	51.50	51.70	51.90			
D1	62.40	62.70	63.00			
Е	34.50	34.70	34.90			
E1	20.00	20.20	20.40			
E2	19.90	20.10	20.30			
е		3.00 BSC				
e1		10.00 BSC				
e2		1.00 BSC				
F	4.80	5.00	5.20			
L	4.00	4.20	4.40			
L1	3.75	3.95	4.15			
q	51.50	51.70	51.90			
ØΑ	3.30	3.40	3.50			

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DETAIL A